

<b>Notice of References Cited</b>	Application/Control No. 10/591,512		Applicant(s)/Patent Under Reexamination KRUGER ET AL.	
	Examiner Duy-Vu N. Deo		Art Unit 1792	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0035085	02-2005	Stowell et al.	216/076
*	B	US-7,451,774	11-2008	Verhaverbeke et al.	134/184
*	C	US-4,141,127	02-1979	Cretella et al.	29/889.1
*	D	US-4,121,894	10-1978	Cretella et al.	416/213R
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.